

Rochester Electronics Manufactured Components

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All recreations are done with the approval of the OCM.

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceed the OCM data sheet.

Quality Overview

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-35835
 - Class Q Military
 - Class V Space Level
- Qualified Suppliers List of Distributors (QSLD)
- Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OEM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.



April 1988 Revised September 2000

74F175 Quad D-Type Flip-Flop

General Description

The 74F175 is a high-speed quad D-type flip-flop. The device is useful for general flip-flop requirements where clock and clear inputs are common. The information on the D inputs is stored during the LOW-to-HIGH clock transition. Both true and complemented outputs of each flip-flop are provided. A Master Reset input resets all flip-flops, independent of the Clock or D inputs, LOW.

Features

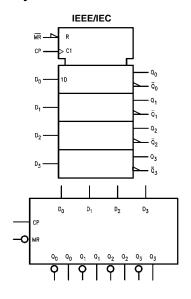
- Edge-triggered D-type inputs
- Buffered positive edge-triggered clock
- Asynchronous common reset
- True and complement output

Ordering Code:

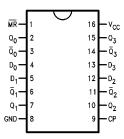
Order Number	Package Number	Package Description
74F175SC	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow
74F175SJ	M16D	16-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74F175PC	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbols



Connection Diagram



Unit Loading/Fan Out

Pin Names	Description	U.L.	Input I _{IH} /I _{IL}	
	Description	HIGH/LOW	Output I _{OH} /I _{OL}	
D ₀ -D ₃	Data Inputs	1.0/1.0	20 μA/-0.6 mA	
СР	Clock Pulse Input (Active Rising Edge)	1.0/1.0	20 μA/-0.6 mA	
MR	Master Reset Input (Active LOW)	1.0/1.0	20 μA/-0.6 mA	
$Q_0 - Q_3$	True Outputs	50/33.3	−1 mA/20 mA	
$\overline{Q}_0 - \overline{Q}_3$	Complement Outputs	50/33.3	−1 mA/20 mA	

Functional Description

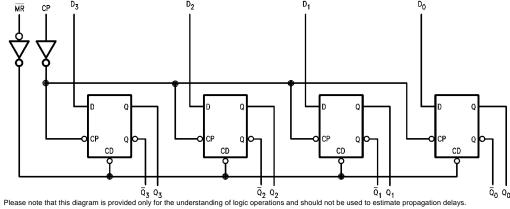
The 74F175 consists of four edge-triggered D-type flipflops with individual D inputs and Q and \overline{Q} outputs. The Clock and Master Reset are common. The four flip-flops will store the state of their individual D inputs on the LOW-to-HIGH clock (CP) transition, causing individual Q and $\overline{\mathbb{Q}}$ outputs to follow. A LOW input on the Master Reset (\overline{MR}) will force all Q outputs LOW and \overline{Q} outputs HIGH independent of Clock or Data inputs. The 74F175 is useful for general logic applications where a common Master Reset and Clock are acceptable.

Truth Table

	Inputs	Outputs			
MR CP		D _n	Q_n	$\overline{\mathbf{Q}}_{\mathbf{n}}$	
L	Х	Х	L	Н	
Н	~	Н	Н	L	
Н	~	L	L	Н	

H = HIGH Voltage Level

Logic Diagram



L = LOW Voltage Level

X = Immaterial

^{∠ =} LOW-to-HIGH Clock Transition

Absolute Maximum Ratings(Note 1)

-65°C to +150°C Storage Temperature Ambient Temperature under Bias -55°C to +125°C

Junction Temperature under Bias -55°C to +150°C V_{CC} Pin Potential to Ground Pin -0.5V to +7.0VInput Voltage (Note 2) -0.5V to +7.0V

-30 mA to +5.0 mA

Input Current (Note 2) Voltage Applied to Output

in HIGH State (with $V_{CC} = 0V$)

Standard Output -0.5V to V_{CC}

3-STATE Output -0.5V to +5.5V

Current Applied to Output

in LOW State (Max) twice the rated I_{OL} (mA)

Recommended Operating Conditions

Free Air Ambient Temperature 0°C to +70°C Supply Voltage +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

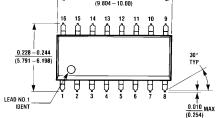
Symbol	Parameter		Min	Тур	Max	Units	V _{CC}	Conditions
V _{IH}	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal
V _{IL}	Input LOW Voltage				8.0	V		Recognized as a LOW Signal
V _{CD}	Input Clamp Diode Voltage				-1.2	V	Min	I _{IN} = -18 mA
V _{OH}	Output HIGH	10% V _{CC}	2.5			V	Min	I _{OH} = -1 mA
	Voltage	$5\% V_{CC}$	2.7			V	IVIIII	$I_{OH} = -1 \text{ mA}$
V _{OL}	Output LOW	10% V _{CC}			0.5	V	Min	I _{OL} = 20 mA
	Voltage				0.5	V	IVIIII	10L - 20 IIIA
I _{IH}	Input HIGH				5.0	μА	Max	V _{IN} = 2.7V
	Current				3.0	μΛ	IVIAX	V N = 2.7 V
I _{BVI}	Input HIGH Current				7.0	μА	Max	V _{IN} = 7.0V
	Breakdown Test				7.0	μΛ	IVICA	V _{IN} = 7.0 V
I _{CEX}	Output HIGH				50	μА	Max	V _{OUT} = V _{CC}
	Leakage Current				30	μΛ	IVICA	v001 = vCC
V _{ID}	Input Leakage		4.75	V		V	0.0	I _{ID} = 1.9 μA
	Test		4.75				0.0	All Other Pins Grounded
I _{OD}	Output Leakage				3.75	μА	0.0	$V_{IOD} = 150 \text{ mV}$
	Circuit Current				3.73	μΛ	0.0	All Other Pins Grounded
I _{IL}	Input LOW Current				-0.6	mA	Max	V _{IN} = 0.5V
los	Output Short-Circuit Current		-60		-150	mA	Max	V _{OUT} = 0V
I _{CC}	Power Supply Current			22.5	34.0	mA	Max	CP = _
								$D_n = \overline{MR} = HIGH$

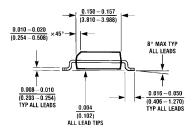
AC Electrical Characteristics

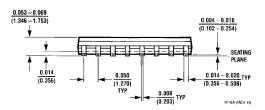
Symbol	Parameter	$T_{A} = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$			$T_{A} = -55^{\circ}C \text{ to } +125^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$		$T_A = 0$ °C to +70°C $V_{CC} = +5.0V$ $C_L = 50$ pF		Units
		Min	Тур	Max	Min	Max	Min	Max	
f _{MAX}	Maximum Clock Frequency	100	140		80		100		MHz
t _{PLH}	Propagation Delay	4.0	5.0	6.5	3.5	8.5	4.0	7.5	
t_{PHL}	CP to Q _n or Q _n	4.0	6.5	8.5	4.0	10.5	4.0	9.5	ns
t _{PHL}	Propagation Delay MR to Q _n	4.5	9.0	11.5	4.5	15.0	4.5	13.0	ns
t _{PLH}	Propagation Delay MR to Qn	4.0	6.5	8.0	4.0	10.0	4.0	9.0	ns

AC Operating Requirements

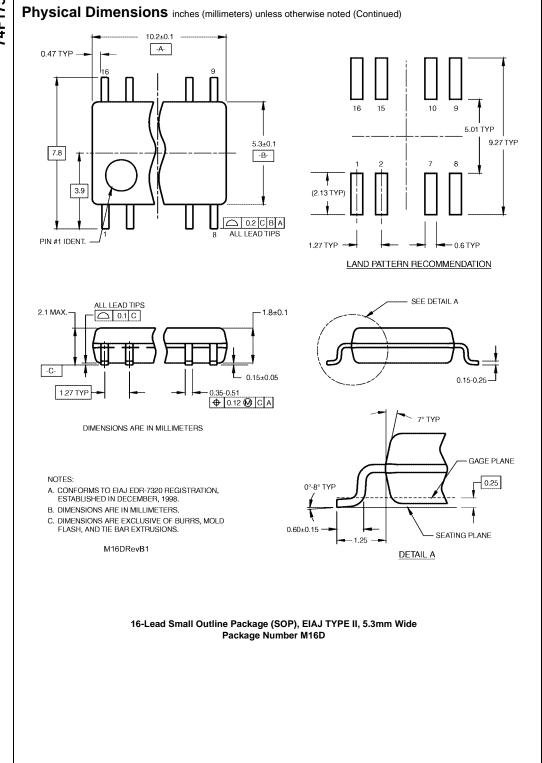
Symbol	Parameter	$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$		$T_A = -55^{\circ}C \text{ to } +125^{\circ}C$ $V_{CC} = +5.0V$		$T_A = 0$ °C to +70°C $V_{CC} = +5.0V$		Units
		Min	Max	Min	Max	Min	Max	
t _S (H)	Setup Time, HIGH or LOW	3.0		3.0		3.0		
t _S (L)	D _n to CP	3.0		3.0		3.0		ns
t _H (H)	Hold Time, HIGH or LOW	1.0		1.0		1.0		
$t_H(L)$	D _n to CP	1.0		2.0		1.0		
t _W (H)	CP Pulse Width	4.0		4.0		4.0		ns
$t_W(L)$	HIGH or LOW	5.0		5.0		5.0		115
t _W (L)	MR Pulse Width, LOW	5.0		5.0		5.0		ns
t _{REC}	Recovery Time, MR to CP	5.0		5.0		5.0		ns







16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow Package Number M16A



Physical Dimensions inches (millimeters) unless otherwise noted (Continued) 0.740 - 0.780 0.090 (18.80 - 19.81)(2.286) 16 15 14 13 12 11 10 9 16 15 INDEX ARFA 0.250 ± 0.010 $\overline{(6.350 \pm 0.254)}$ PIN NO. 1 PIN NO. 1 1 2 3 4 5 6 7 8 1 2 IDENT OPTION 01 OPTION 02 0.065 $\frac{0.130 \pm 0.005}{(3.302 \pm 0.127)}$ $\frac{0.060}{(1.524)}$ TYP 4º TYP OPTIONAL (1.651)0.300 - 0.320 (7.620 - 8.128) 0.145 - 0.200 (3.683 - 5.080)95° ± 5° 0.008 - 0.016 (0.203 - 0.406) TYP 0.020 $\frac{0.280}{(7.112)}$ (0.508)0.125 - 0.150 (3.175 - 3.810) 0.030 ± 0.015 (0.762 ± 0.381) 0.014 - 0.0230.100 ± 0.010 (0.325 +0.040 -0.015 (0.356 - 0.584)0.050 ± 0.010 (2.540 ± 0.254) N16E (REV F) (1.270 ± 0.254)

16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N16E

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